



LS Research Inc.

Surveillance Transmitter

Part 90 Type Acceptance, Conducted Measurements

prepared for

Audio Intelligence Devices



Table of Contents

I. PROJECT INFORMATION	3
II. FCC CONDUCTED TESTS.....	5
A. PART 90 SUBPART I	5
1. 90.207 (a) (1) Types of Emmissions (Device Classification).....	5
2. 90.209 (a) (5) Bandwidth Limitations (Device Classification, Test Condition).....	5
3. Part 2.985 Output Power, Part 2.991 Spurious Emissions at Antenna terminals and Part 2.989 Occupied bandwidth using 90.210 (d) Emission Mask for F3E Transmitter.	6
4. Part 2.995 and 90.213 (a) Frequency Stability.....	18
5. 90.214: Transient Frequency Behavior.	20
6. 2.987 (a), (b) Modulation Characteristics	32
III. EQUIPMENT LIST	37
IV. EQUIPMENT UNCERTAINTIES	37
V. UNCERTAINTY ANALYSIS.....	38



Surveillance Transmitter

I. Project Information

Project: *Surveillance Transmitter*

Manufacturer: Audio Intelligence Devices, Inc.

Model Number: PST 1200

Serial Number: n/a

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Proposal Date: 7/2/01
Revision: 1.2
Proposal #: 859
Proposal File: AID Transmitter 1_2
Job Number: 850

Signatures:

Mark Wolski PhD.

Mark Wolski, Ph.D.

March 10, 1999

Technical Approval:

Brian Petted

March 10, 1999



II. FCC Conducted Tests

A. Part 90 Subpart I

1. 90.207 (a) (1) Types of Emissions (Device Classification)

Classified as an **F3E** emitter (Frequency Modulation, Analog Modulation, Voice). Power levels: 50 mW and 125 mW.

2. 90.209 (a) (5) Bandwidth Limitations (Device Classification, Test Condition).

12.5 kHz Nominal Channel Bandwidth



3. Part 2.985 Output Power, Part 2.991 Spurious Emissions at Antenna terminals and Part 2.989 Occupied bandwidth using 90.210 (d) Emission Mask for F3E Transmitter.

a) Test Requirement:

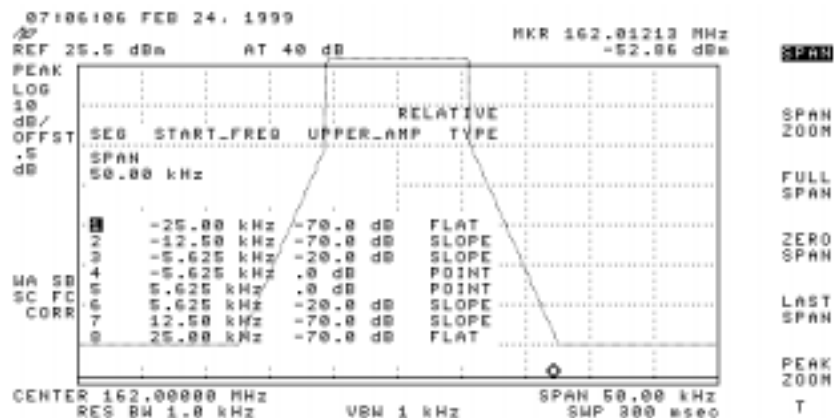
(1) On any frequency from the center of the authorized bandwidth f_o to 5.625 kHz removed from f_o : Zero dB.

(2) On any frequency removed from the center of the authorized bandwidth by a displacement frequency (f_d in kHz) of more than 5.625 kHz but no more than 12.5 kHz: At least $7.27(f_d - 2.88 \text{ kHz})$ dB.

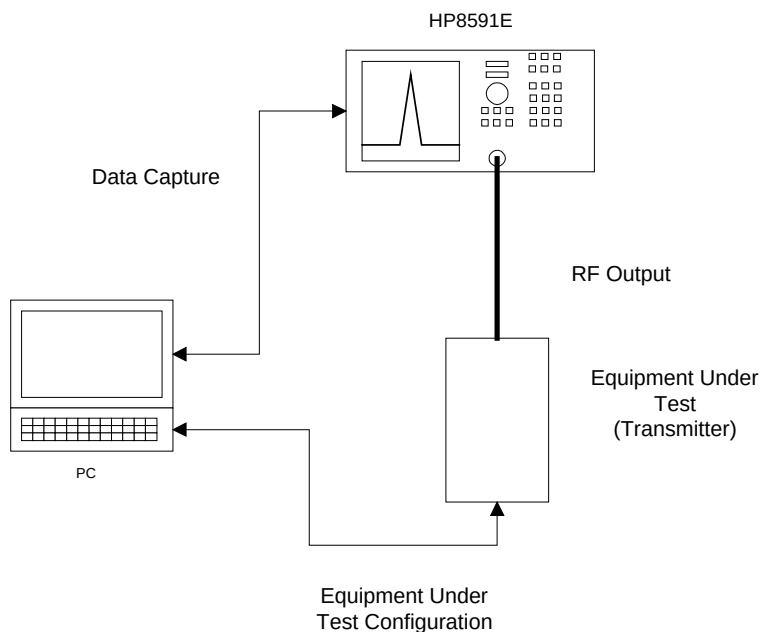
(3) On any frequency removed from the center of the authorized band by a displacement frequency (f_d in kHz) of more than 12.5 kHz : At least $50 + 10 \log(P)$ dB or 70 dB, whichever is the lesser attenuation.

The test condition is presented in Tabular form below. The definition of the spectrum mask as indicated on the spectrum analyzer is also presented.

90.210 (d)	Absolute Frequency Offset Range: $ f_m $	Attenuation relative to Carrier power P.
(1)	0 to 5.625 kHz	0 dB
(2)	5.625 kHz to 12.5 kHz	$7.27(f_m - 2.88)$ dB
(3)	> 12.5 kHz	Min $(50 + 10 \log_{10}(P))$ dB ,70 dB)



b) Test Configuration



c) Test Conditions: Stimulus

Input nominal audio signal at 3 kHz: (1mV).

Set level to 50% rated deviation. (100 % is +/- 1.55 kHz., 50% is 775 Hz)

This level occurs at 4.8 dB down. (equivalent to 1 mV at 1 kHz).

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Set modulating frequency to 2500 Hz

Increase Level by 16 dB: (16 dB-4.8 dB = 11.2 dB = 3.63 mV , 6.31 mV Setting)

Measure Spectrum Mask (D).

d) Equipment Under Test Conditions, Instrument Conditions and Indicated Numerical Data for Part 2.985 Output Power.

Presented below is a table that summarizes the equipment under test conditions, instrument conditions and numerical data. Numerical Data for the Transmitter Power under each of the test conditions is indicated in the Table. The source of the numerical data is presented in sub-sections(e),and (f), Test Indications. Demonstration of compliance is presented in sub-sections (e) and (f).

	Set f (MHz)	Desired Po (dBm)	Set Po (mW)	Trim (count)	Po (dBm)	2nd (dBc)	fcenter (MHz)	span (MHz)	RBW (kHz)	VBW (kHz)	filename (* .pcx)
Conducted Emission - Harmonic Output	150	17	50	0	16.39	43.65	300	500	100	1000	CH1A
						42.89	900	1700	1000	3000	CH1B
		21	125	8	20.43	43.97	300	500	100	1000	CH1C
						43.57	900	1700	1000	3000	CH1D
	162	17	75	-7	16.51	47.86	300	500	100	1000	CH2A
						47.97	900	1700	100	3000	CH2B
		21	150	-32	20.45	51.98	300	500	100	1000	CH2C
						51.94	900	1700	100	3000	CH2D
	174	17	75	-5	16.38	50.10	300	500	100	1000	CH3A
						47.67	900	1700	1000	3000	CH3B
		21	150	23	20.38	50.35	300	500	100	1000	CH3C
						51.37	900	1700	1000	3000	CH3D
Conducted Emission - Occupied Bandwidth	150	21	125	8	20.43		150	10	0.1	0.03	CB1
								0.05	0.1	0.10	
	162	21	150	-32	20.45		162	10	0.1	0.03	CB2
								0.05	0.1	0.10	
	174	21	150	23	20.38		174	10	0.1	0.03	CB3
								0.05	0.1	0.10	

NOTES: Po measured on HP8920A. ADD 0.6 dB for cable loss

6.31 mV rms, 2.5kHz tone used in Occupied bandwidth measurement.

2nd Harmonic must be < 37 dBc (17 dBm output) and 41 dBc (21 dBm output)

Set f : E.U.T Carrier frequency Setting .

Desired Po, Set Po: Nominal E.U.T Power Settings.

Trim: Programming Parameter Setting for output power.

Po: Measured Absolute Output Power (HP8920A)

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2nd : Second Harmonic Level in dB relative to absolute Power

fcenter: Spectrum Analyzer Center Frequency Setting

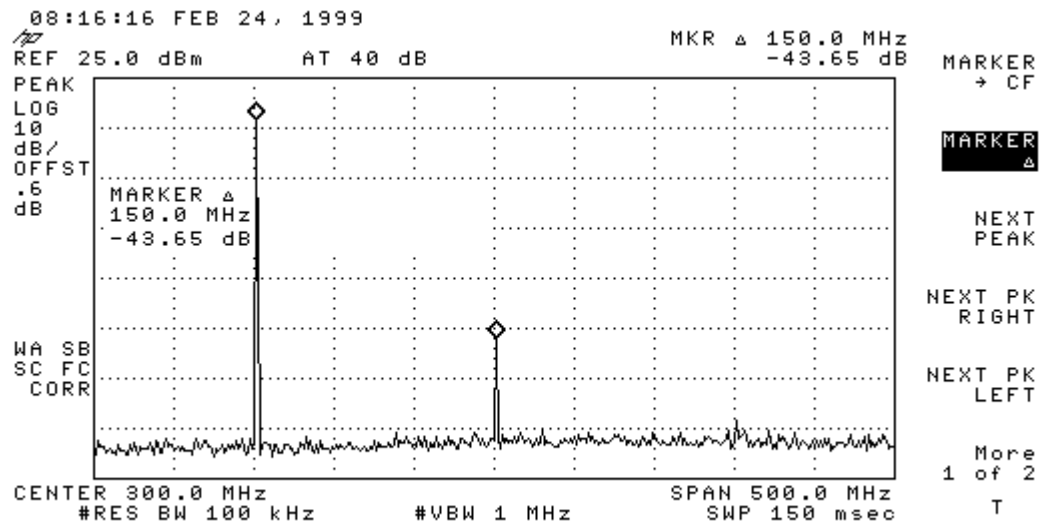
span: Spectrum Analyzer Frequency Span Setting.

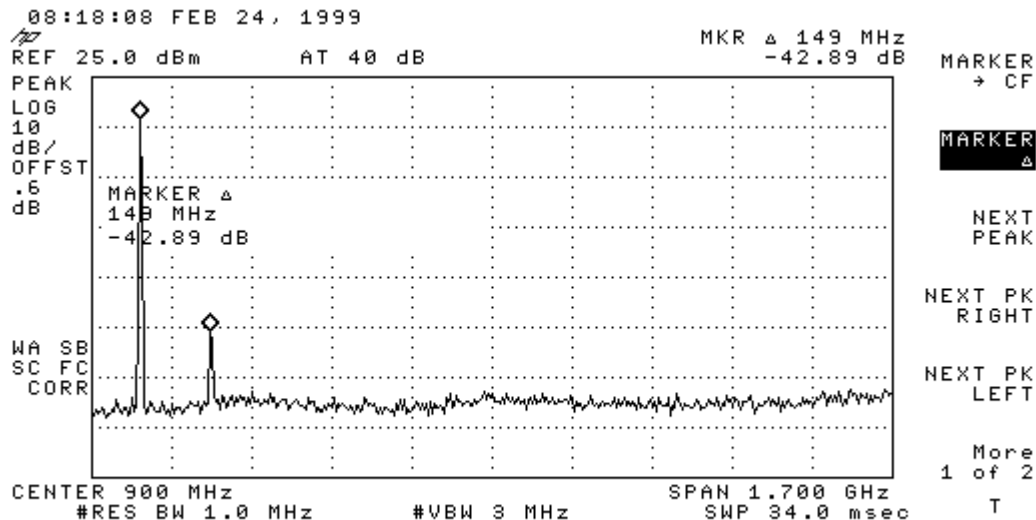
RBW: Spectrum Analyzer Resolution Bandwidth.

VBW: Spectrum Analyzer Video Bandwidth.

Filename: Data Capture Filename

e) Test Indications Part 2. 991 Conducted Spurious Emissions at Antenna Terminals



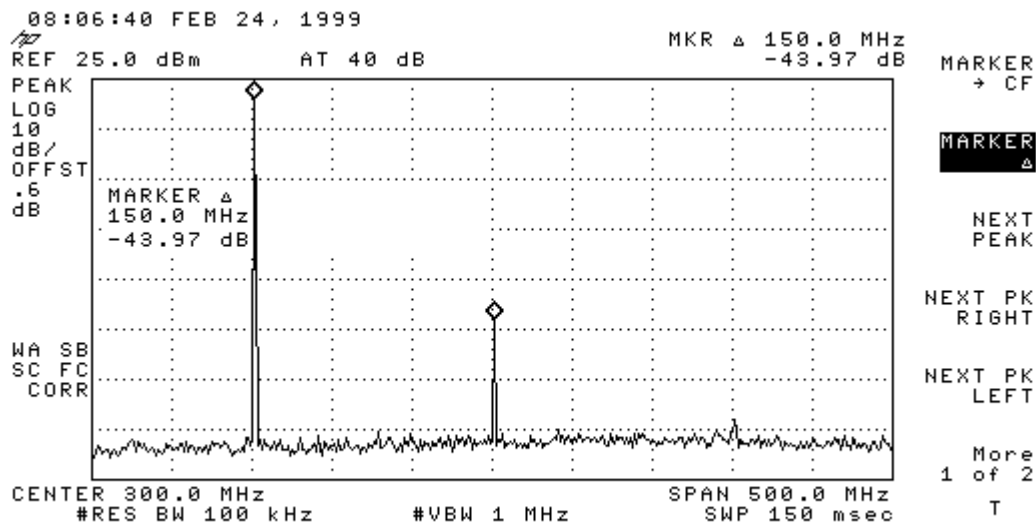


Test Condition: 150 MHz, 50 mW

Test Limit: $10 \log (0.050 \text{ W}) + 50 \text{ dB} = 37 \text{ dBc}$

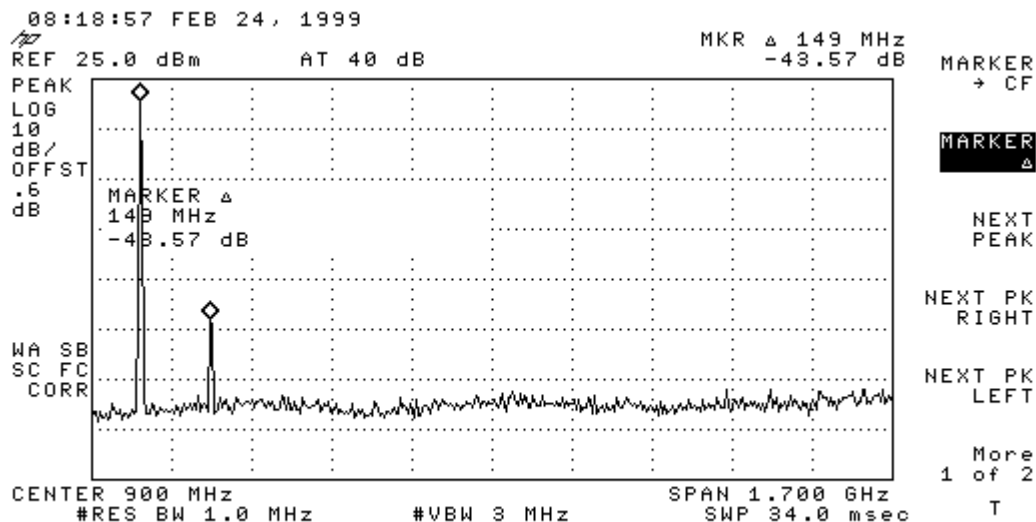
Test Indication: 42.9 dBc

Test Outcome: 42.9 dBc > 37 dBc → PASS



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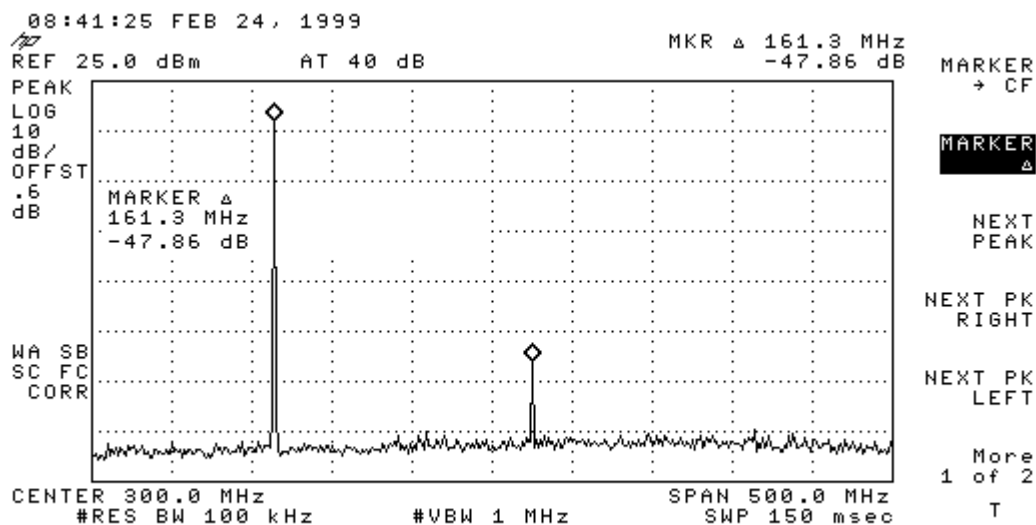


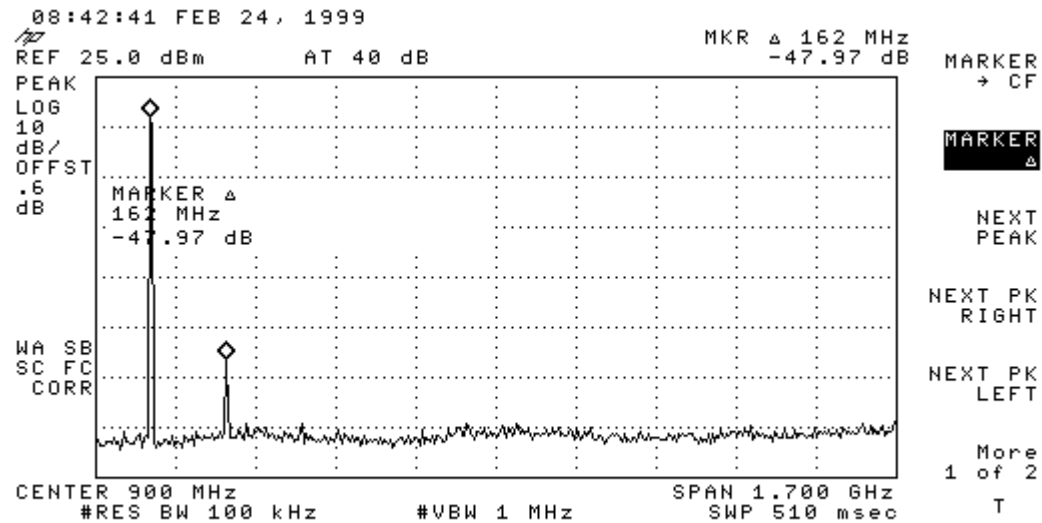
Test Condition: 150 MHz, 125 mW

Test Limit: $10 \log (0.125 \text{ W}) + 50 \text{ dB} = 41 \text{ dBc}$

Test Indication: 43.6 dBc

Test Outcome: 43.6 dBc > 41 dBc → PASS



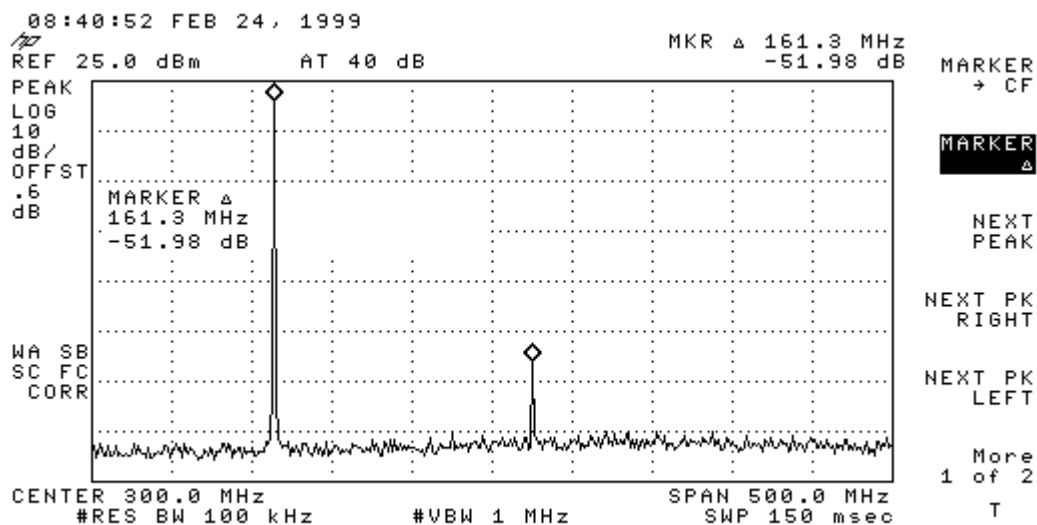


Test Condition: 162 MHz, 50 mW

Test Limit: $10 \log (0.050 \text{ W}) + 50 \text{ dB} = 37 \text{ dBc}$

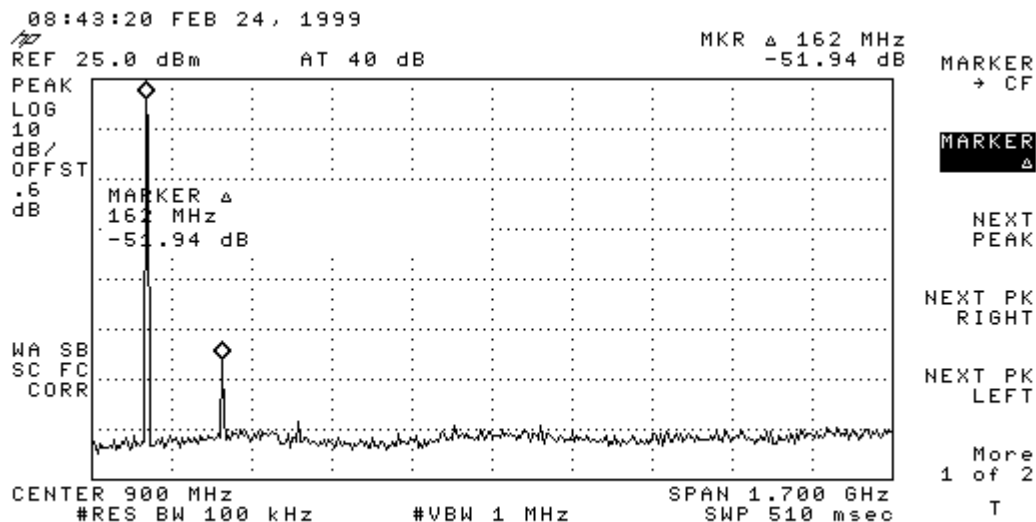
Test Indication: 47.9 dBc

Test Outcome: 47.9 dBc > 37 dBc → PASS



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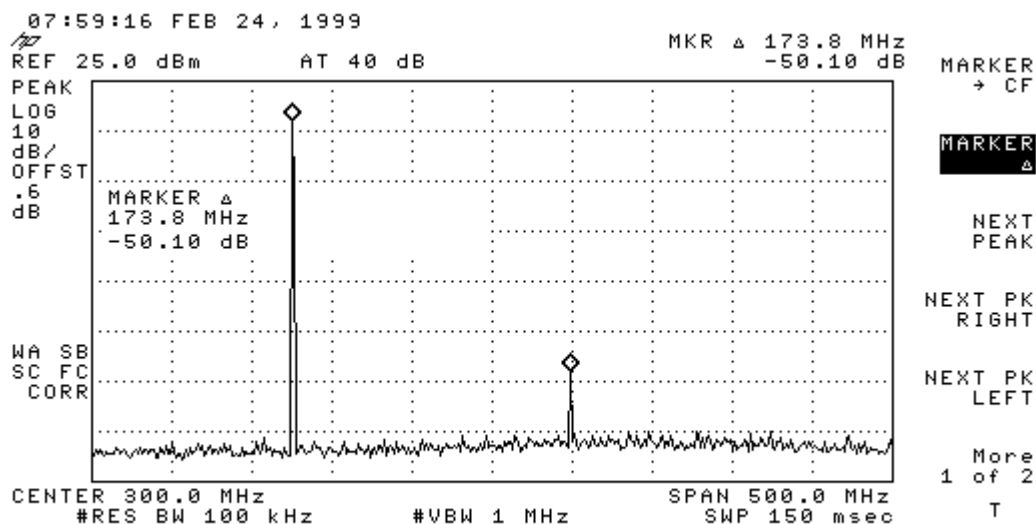


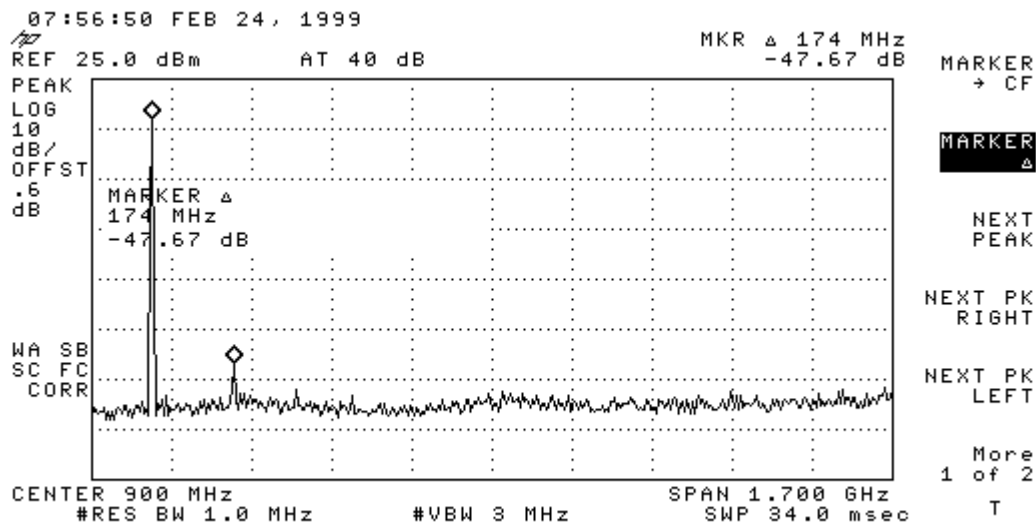
Test Condition: 162 MHz, 125 mW

Test Limit: $10 \log (0.125 \text{ W}) + 50 \text{ dB} = 41 \text{ dBc}$

Test Indication: 51.9 dBc

Test Outcome: 51.9 dBc > 41 dBc → PASS



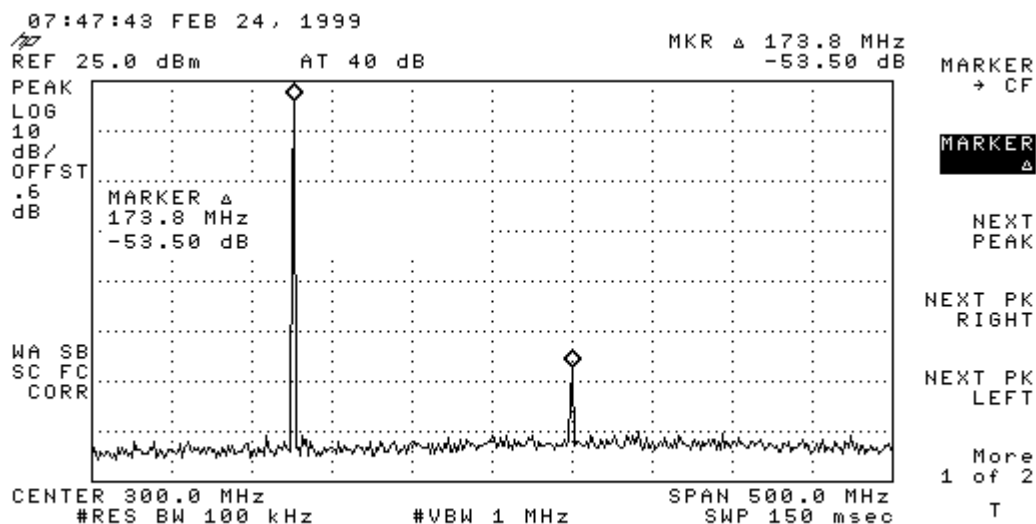


Test Condition: 174 MHz, 50 mW

Test Limit: $10 \log (0.050 \text{ W}) + 50 \text{ dB} = 37 \text{ dBc}$

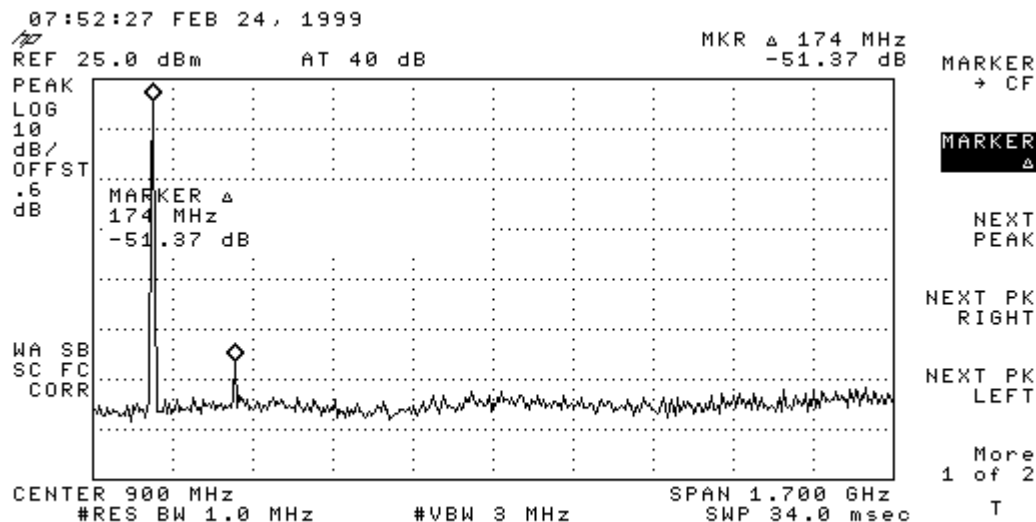
Test Indication: 47.7 dBc

Test Outcome: 47.7 dBc > 37 dBc → PASS



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Test Condition: 174 MHz, 125 mW

Test Limit: $10 \log (0.125 \text{ W}) + 50 \text{ dB} = 41 \text{ dBc}$

Test Indication: 51.9 dBc

Test Outcome: 51.2 dBc > 41 dBc → PASS

f) Test Indications Part 2. 989 Occupied Bandwidth

1. Deviation Set as indicated in Stimulus Test Conditions.
2. ALC Mode presented as worst case.
3. Reference Level setting under these conditions:
 - (a) Span = 10 MHz.
 - (b) Resolution Bandwidth = 100 kHz.
 - (c) Video Bandwidth = 100 kHz.
 - (d) Peak hold and Display, Set Reference Level to Peak.
4. Measurement Indication under these conditions:
 - (a) Span = 50 kHz

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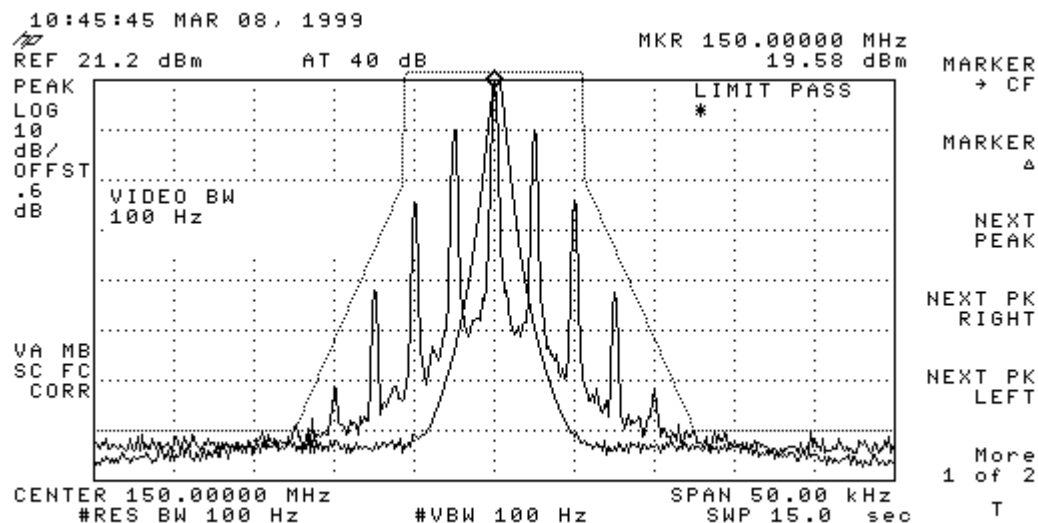
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(b) Resolution Bandwidth = 100 Hz.

(c) Video Bandwidth = 100 Hz.

(d) Peak Hold for > 10 Sweeps



Test Condition: 150 MHz, 125 mW

Test Limit: Indicated Mask (see sub-section (a))

Test Indication: Indicated Spectrum falls below Indicated Mask

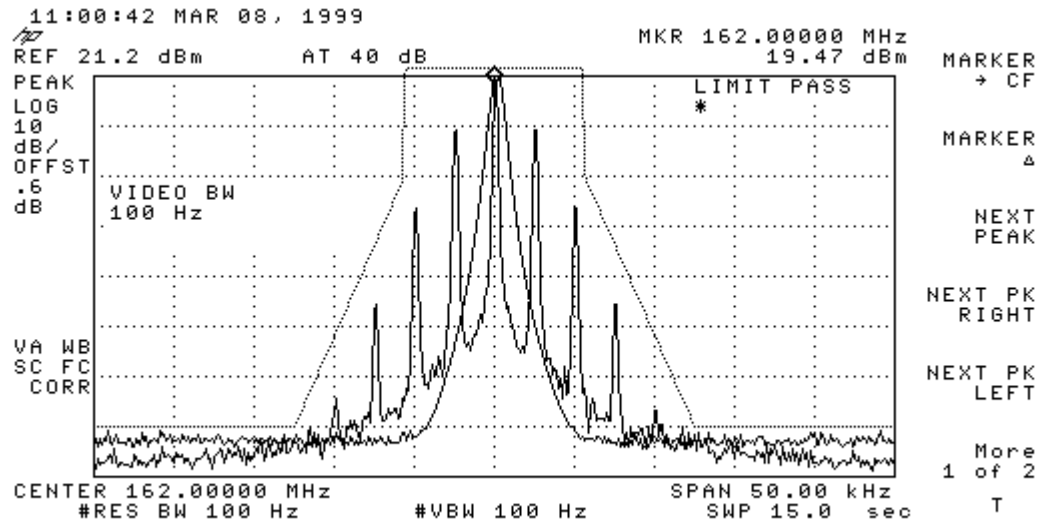
Test Outcome: Spectrum falls below Indicated Mask → PASS

1. Deviation Set as indicated in Stimulus Test Conditions.
2. ALC Mode presented as worst case.
3. Reference Level setting under these conditions:
 - (a) Span = 10 MHz.
 - (b) Resolution Bandwidth = 100 kHz.
 - (c) Video Bandwidth = 100 kHz.
 - (d) Peak hold and Display, Set Reference Level to Peak.
4. Measurement Indication under these conditions:
 - (a) Span = 50 kHz
 - (b) Resolution Bandwidth = 100 Hz.



(c) Video Bandwidth = 100 Hz.

(d) Peak Hold for > 10 Sweeps



Test Condition: 162 MHz, 125 mW

Test Limit: Indicated Mask (see sub-section (a))

Test Indication: Indicated Spectrum falls below Indicated Mask

Test Outcome: Spectrum falls below Indicated Mask → PASS

1. Deviation Set as indicated in Stimulus Test Conditions.
2. ALC Mode presented as worst case.
3. Reference Level setting under these conditions:
 - (a) Span = 10 MHz.
 - (b) Resolution Bandwidth = 100 kHz.
 - (c) Video Bandwidth = 100 kHz.
 - (d) Peak hold and Display, Set Reference Level to Peak.
4. Measurement Indication under these conditions:
 - (a) Span = 50 kHz

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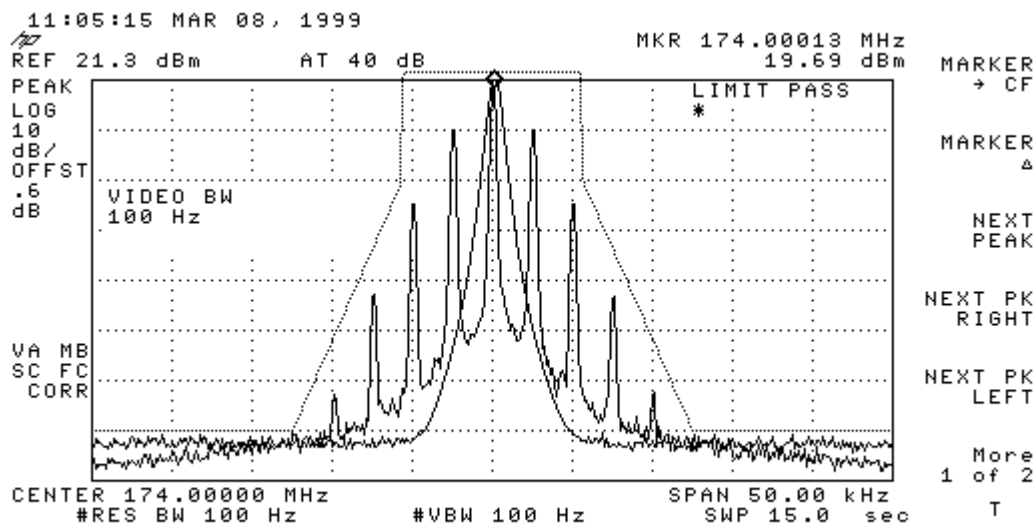
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(b) Resolution Bandwidth = 100 Hz.

(c) Video Bandwidth = 100 Hz.

(d) Peak Hold for > 10 Sweeps



Test Condition: 174 MHz, 125 mW

Test Limit: Indicated Mask (see sub-section (a))

Test Indication: Indicated Spectrum falls below Indicated Mask

Test Outcome: Spectrum falls below Indicated Mask → PASS

4. Part 2.995 and 90.213 (a) Frequency Stability

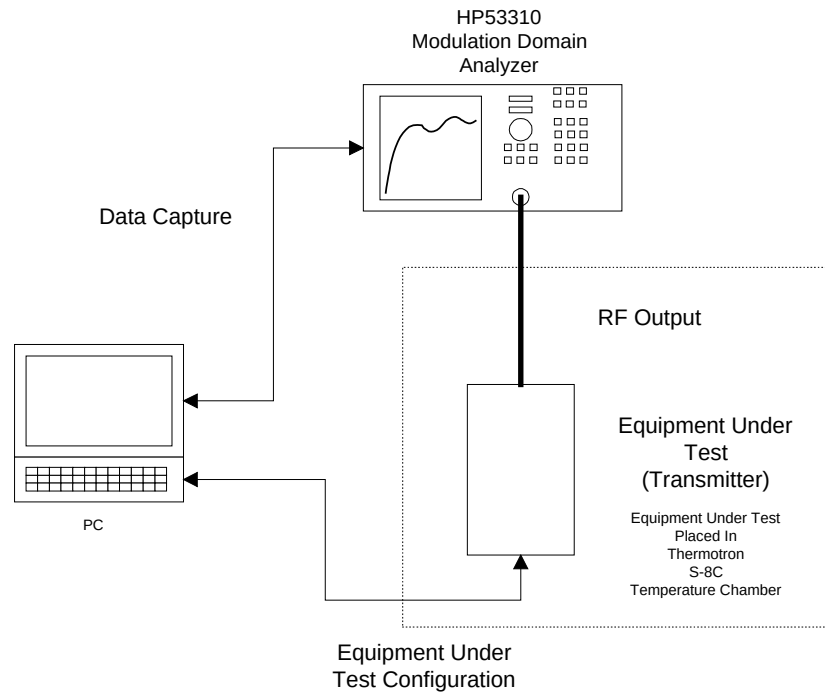
a) Test Requirement

Mobile stations below 2W output power must have an absolute frequency stability of 5 ppm when operating with a 12.5 kHz bandwidth.

Test in accordance to conditions called out in Part 2.995 (a) (1): Frequency stability must be measured from -30 to 50 degrees centigrade for (b) steps of 10 degrees allowing for thermal equilibrium.



b) Test Configuration



c) Test Conditions, Numerical Test Indications



Frequency stability:
fo=162 MHz, Po=125 mW

Set T (deg. C)	Measured T (deg. C)	Measurement Accuracy Range		f (MHz)	ppm w.r.t. 25 deg. C	ppm absolute
		Min. T (deg. C)	Max. T (deg. C)			
-30	-26	-28.13	-26.27	162.00054873	2.05	3.39
-20	-18	-20.09	-18.19	162.00038617	1.05	2.38
-10	-8	-10.04	-8.09	162.00022316	0.04	1.38
0	1	-1.00	1.00	162.00016845	-0.30	1.04
10	11	9.06	11.10	162.00015356	-0.39	0.95
20	21	19.11	21.20	162.00018148	-0.22	1.12
25	25	23.13	25.24	162.00021648	0.00	1.34
30	30	28.15	30.29	162.00025040	0.21	1.55
40	40	38.20	40.39	162.00033670	0.74	2.08
50	50	48.25	50.49	162.00038933	1.07	2.40

Test Condition: 162 MHz, 125 mW (-30 deg. C to 50 deg C, 10 degree steps)

Test Limit: 5 ppm Maximum Frequency Offset

Test Indication:

Maximum Frequency Offset is 3.39 ppm and 2.05 ppm Relative to 25 deg C.

Test Outcome: 3.39 ppm and 2.05 ppm < 5 ppm → PASS

5. 90.214: Transient Frequency Behavior.

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a) Test Requirement

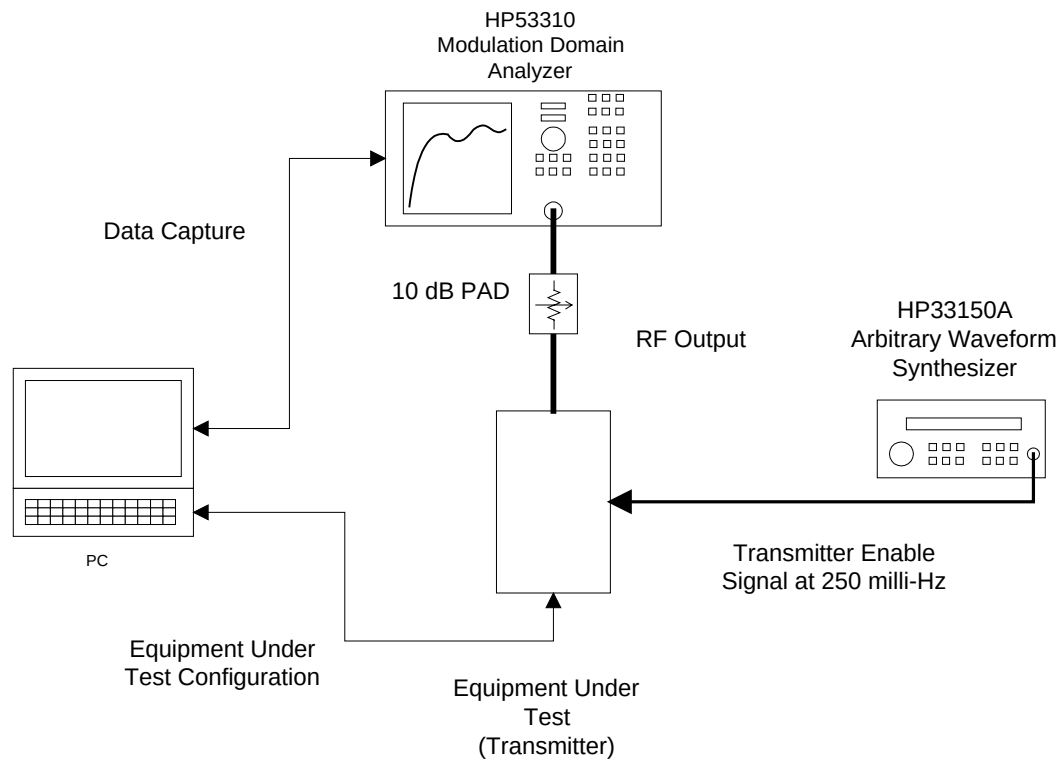
Transmitters designed to operate within the 150 to 174 MHz bands must maintain transient frequencies within the maximum frequency difference during the time intervals indicated in the table below. This device is designed to operate on 12.5 kHz channel bandwidth. The output power of the device is less than 6 Watts, therefore the transient frequency can exceed the limit for the time intervals t_{on} to t_1 and t_{off} to t_3 .

The time, t_{on} , is defined when the transmitter power exceeds -13 dBm at the transmitter output. The modulation domain analyzer is triggered on the envelope of the RF power and the zero time indication is reference to this trigger level. The time, t_{off} , is defined when the transmitter is turned off and the power level falls below -13 dBm.

Time Interval	Transient Frequency Limit	Settling Time
t_1	± 12.5 kHz	5.0 mS
t_2	± 6.25 kHz	25.0 mS
t_3	± 12.5 kHz	5.0 mS

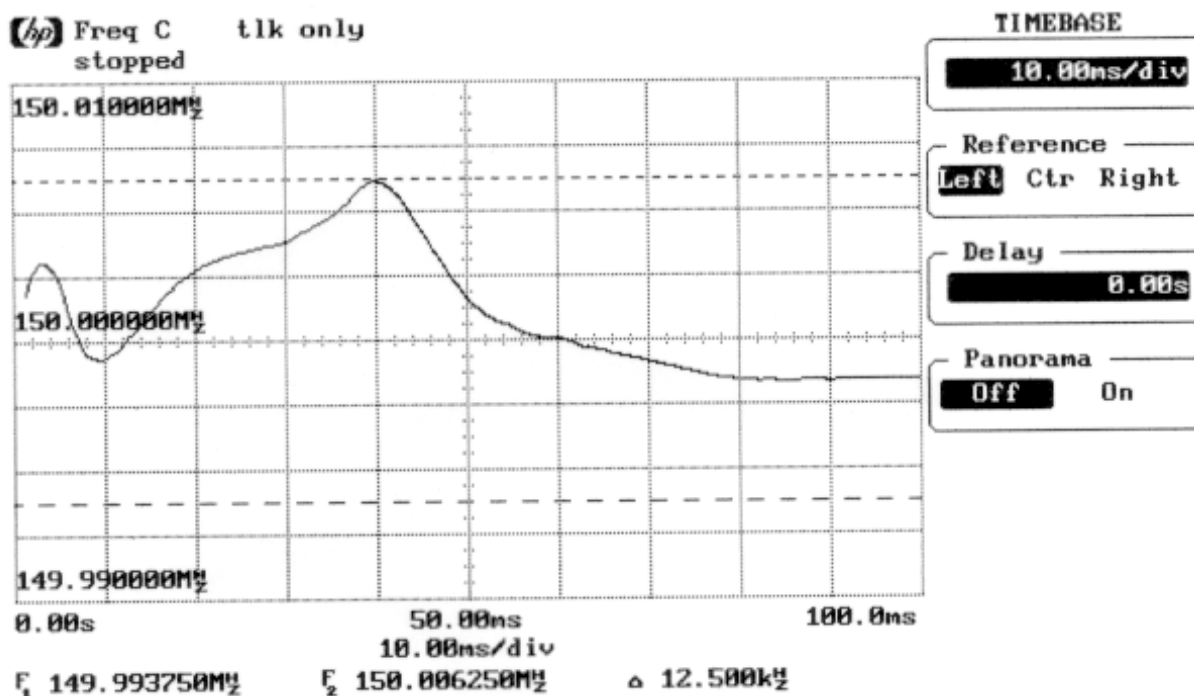


b) Test Configuration





c) Test Conditions and Test Indications

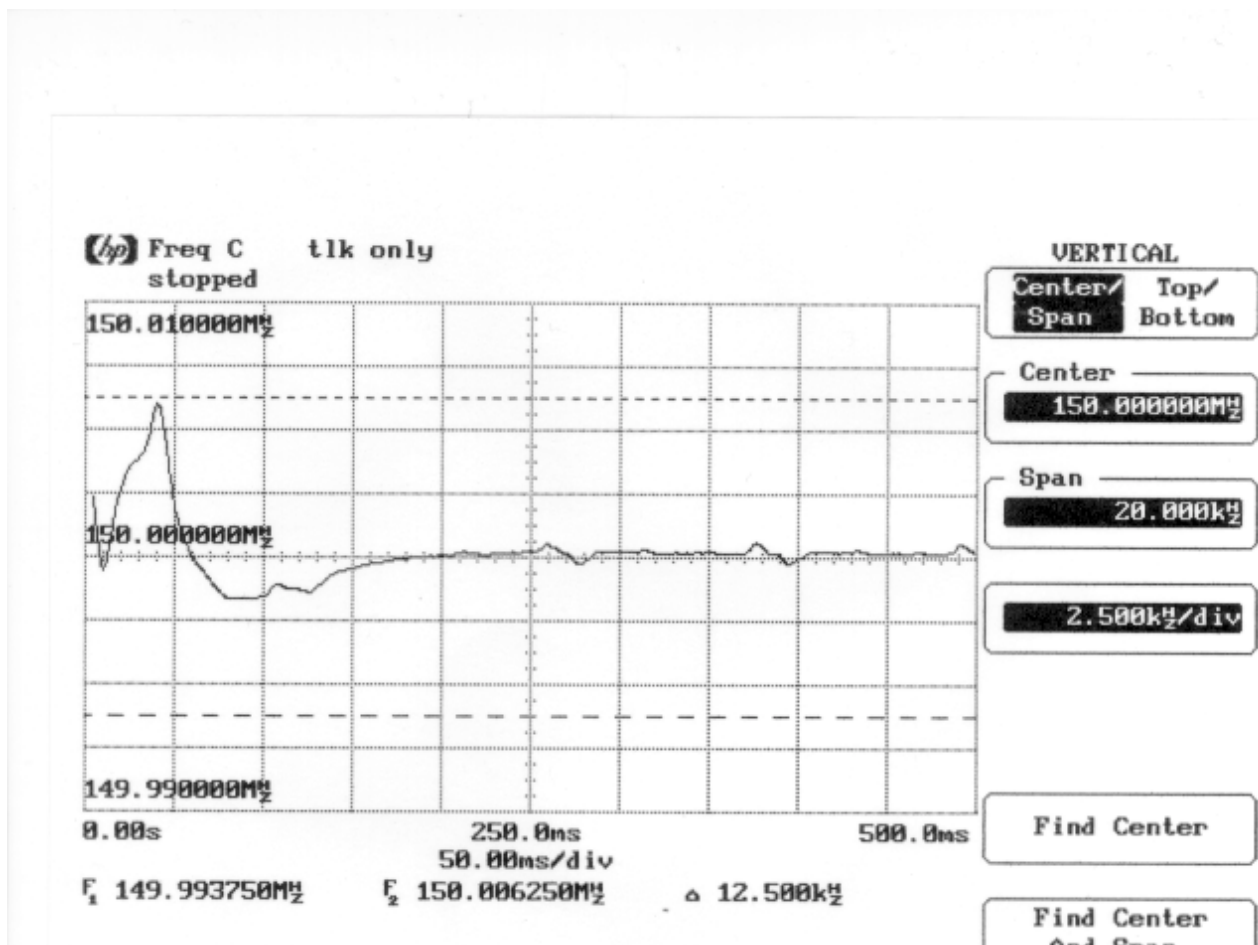


Test Condition: 150 MHz, 125 mW. Frequency Up to 100 mS

Test Limit: ± 12.5 kHz within 5 mS, ± 6.25 kHz within 25 mS

Test Indication: Transient Frequency $< \pm 6.25$ kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits $\rightarrow$ Pass.

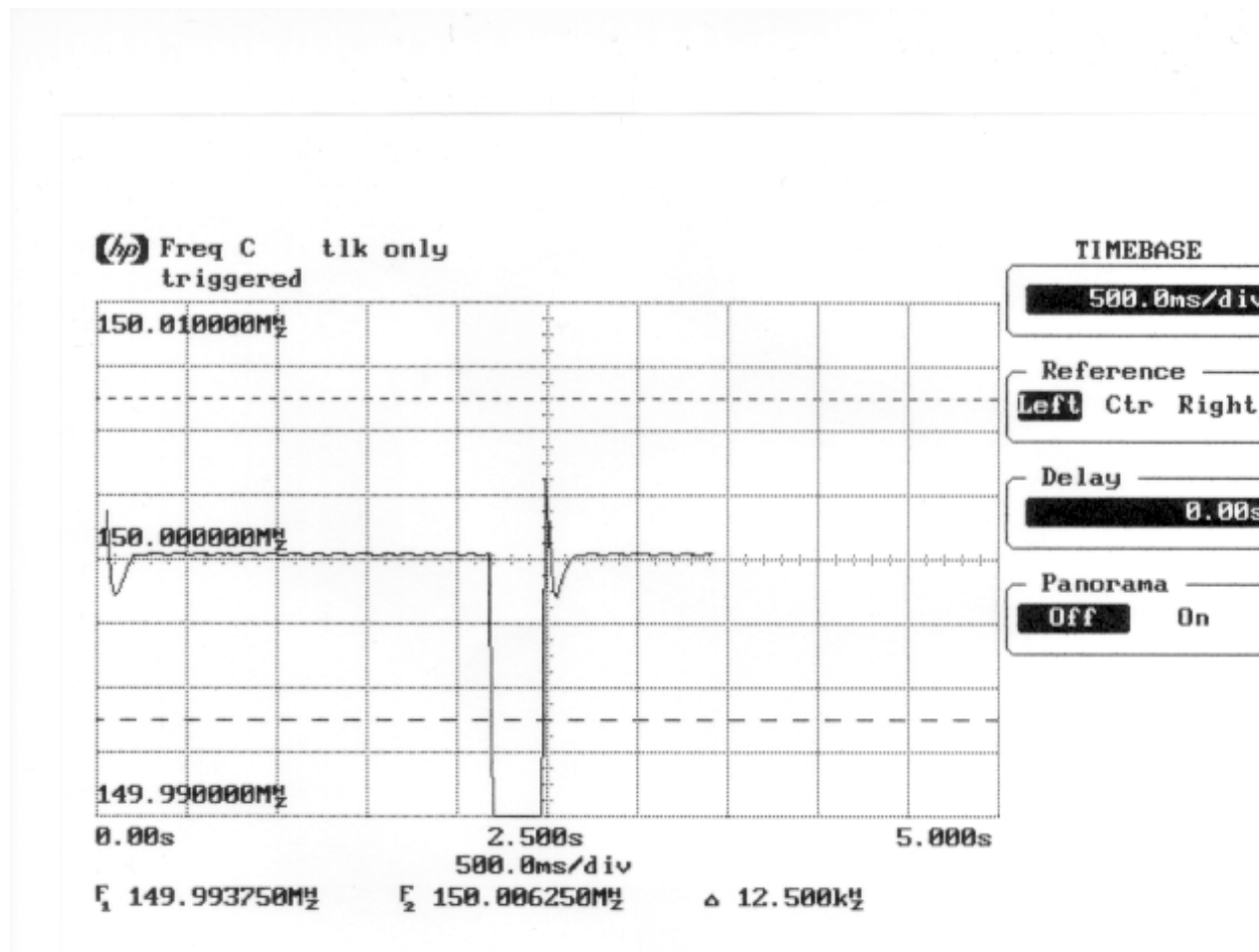


Test Condition: 150 MHz, 125 mW. Frequency Up to 500 mS

Test Limit: ± 12.5 kHz within 5 mS, ± 6.25 kHz within 25 mS

Test Indication: Transient Frequency $< \pm 6.25$ kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits $\rightarrow$ Pass.

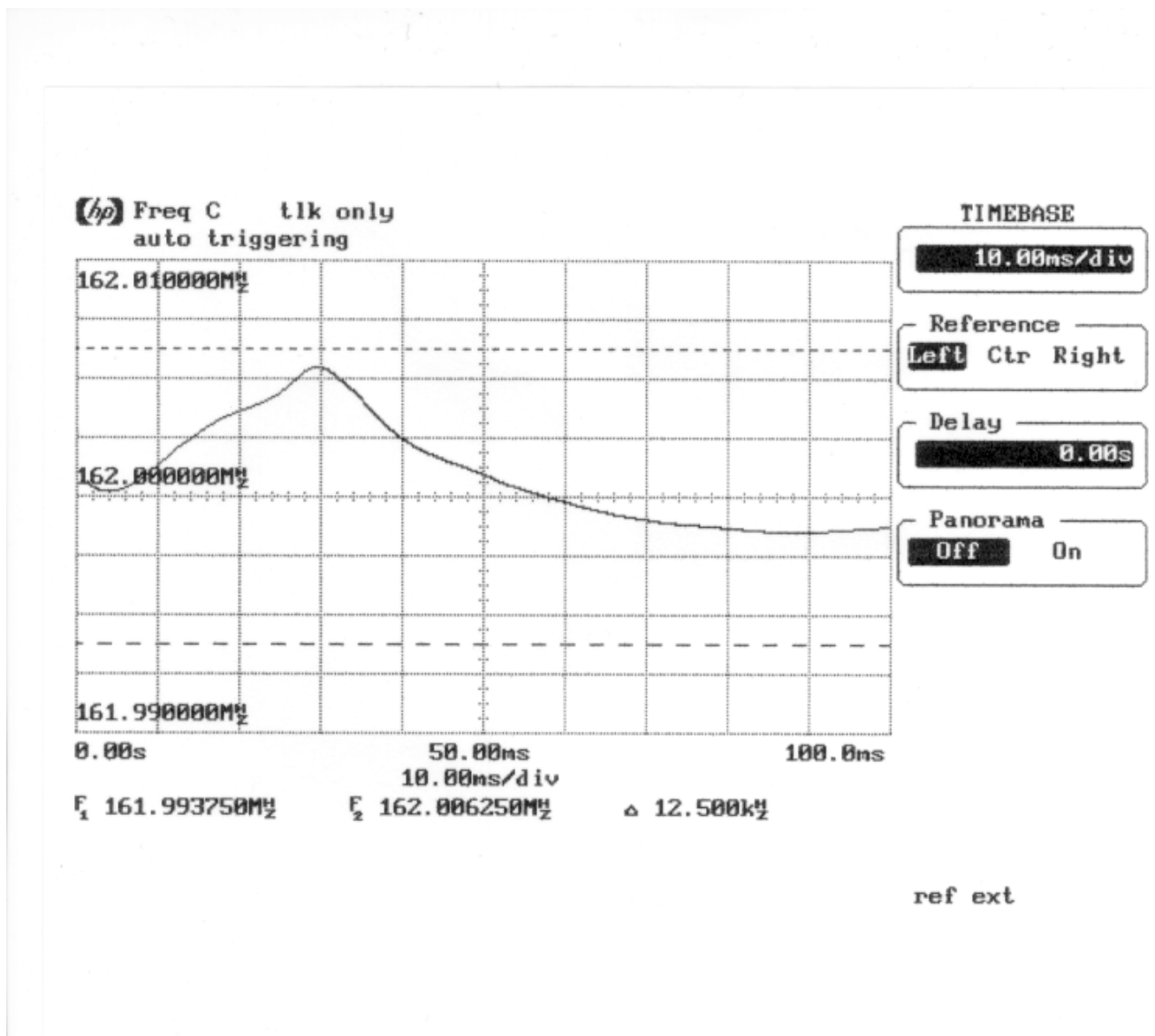


Test Condition: 150 MHz, 125 mW. Transmitter Release Transient Frequency.

Test Limit: ± 12.5 kHz within 5 mS of t_{off}

Test Indication: Transmitter exhibits no post-release transient behavior, power level drops below -13 dBm. .

Test Outcome: Transient Frequency within limits → Pass.



Test Condition: 162 MHz, 125 mW. Frequency Up to 100 mS

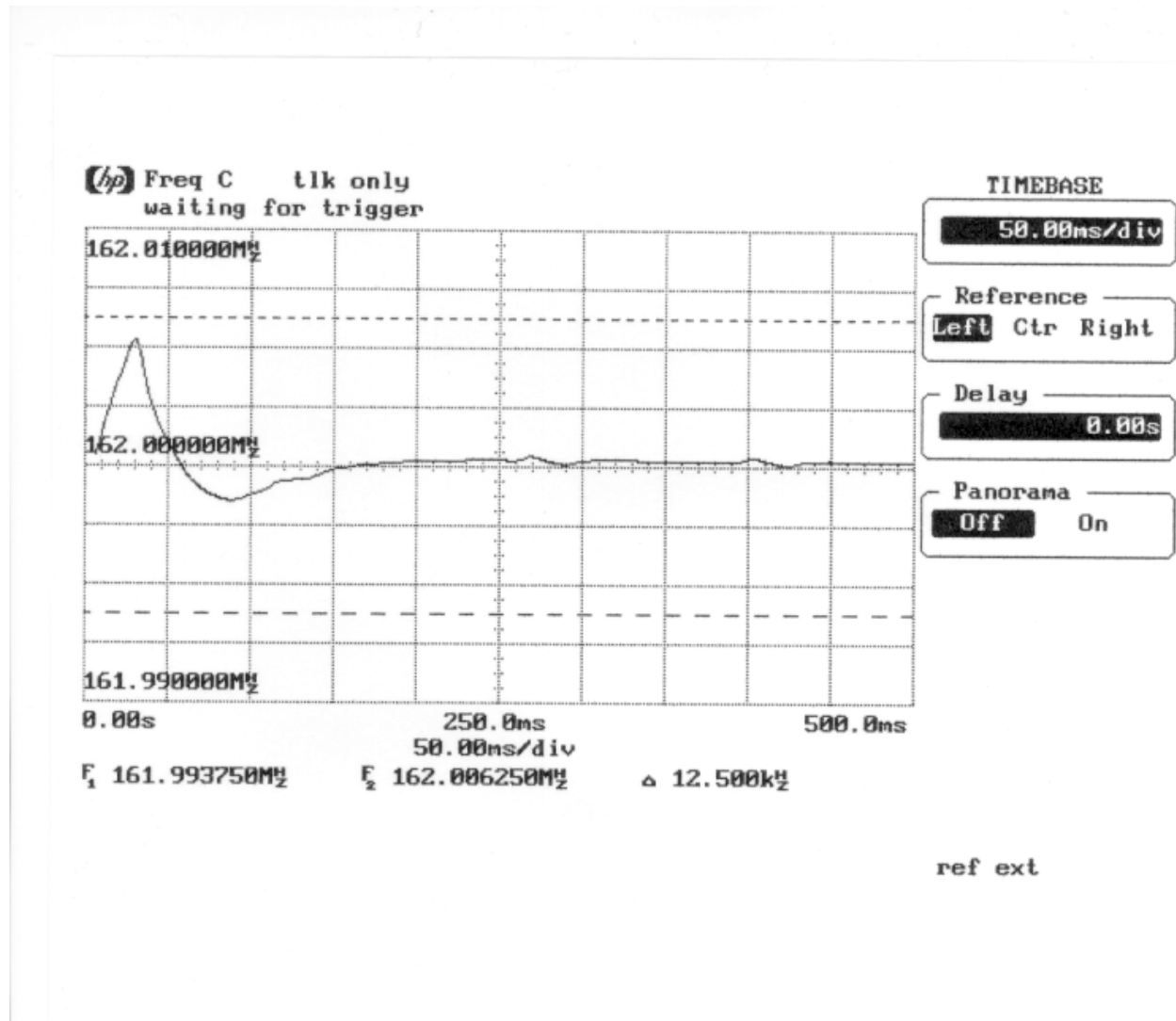
Test Limit: ± 12.5 kHz within 5 mS, ± 6.25 kHz within 25 mS

Test Indication: Transient Frequency $< \pm 6.25$ kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits $\rightarrow$ Pass.

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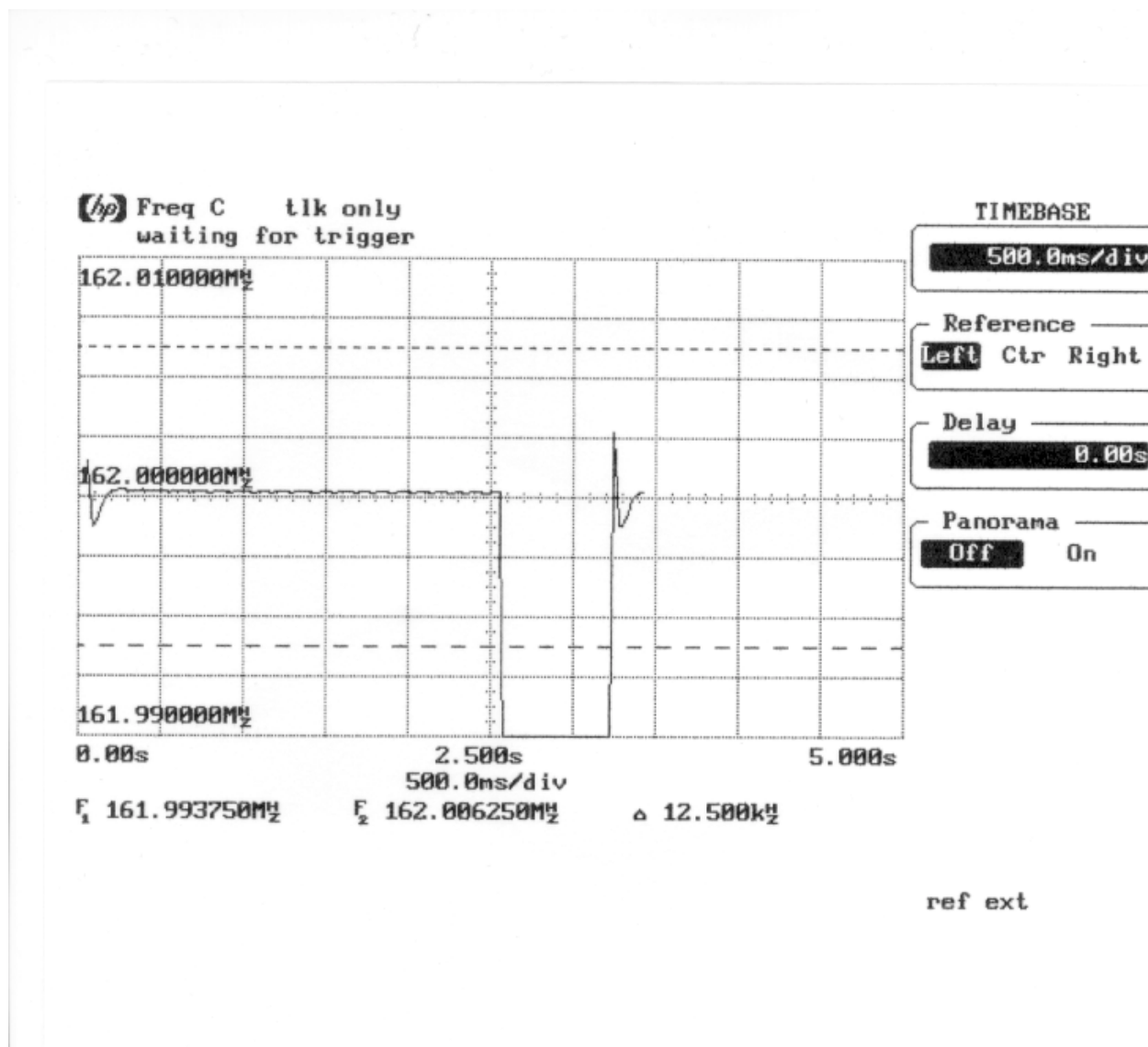


Test Condition: 162 MHz, 125 mW. Frequency Up to 500 mS

Test Limit: ± 12.5 kHz within 5 mS, ± 6.25 kHz within 25 mS

Test Indication: Transient Frequency $< \pm 6.25$ kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits $\rightarrow$ Pass.



Test Condition: 162 MHz, 125 mW. Transmitter Release Transient Frequency.

Test Limit: ± 12.5 kHz within 5 mS of t_{off}

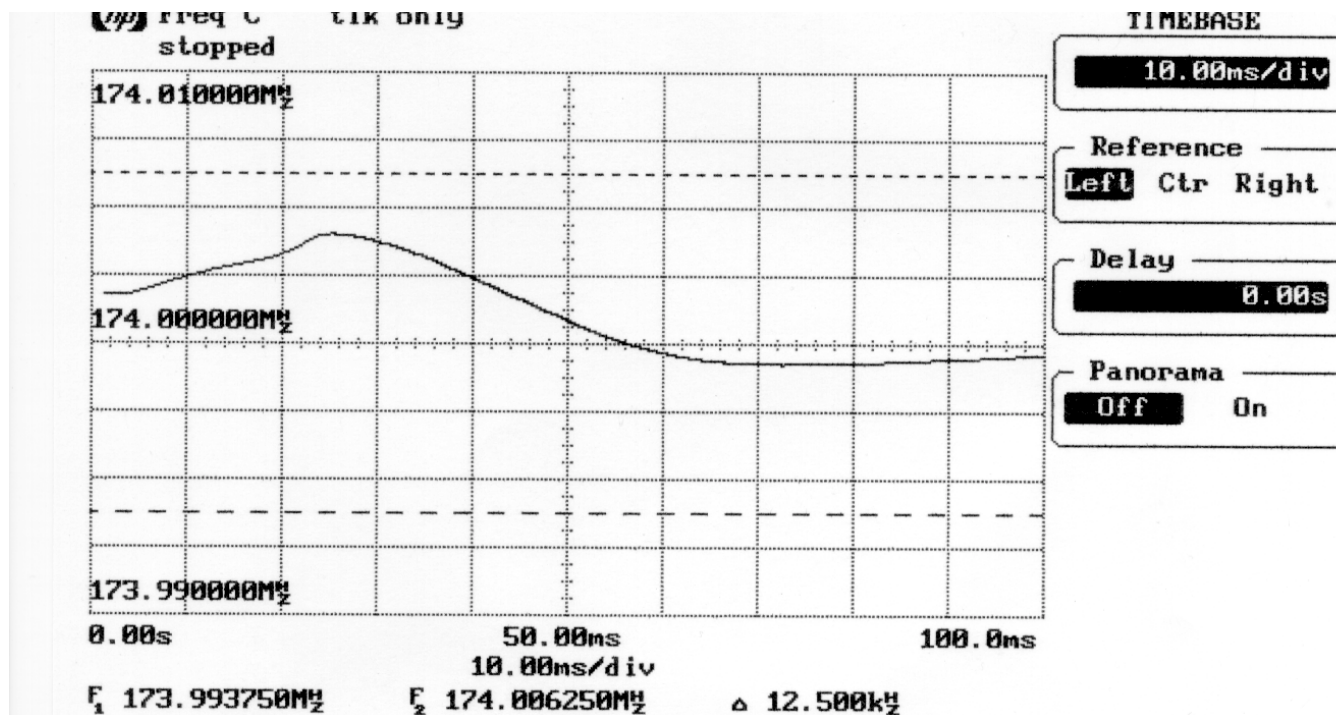
Test Indication: Transmitter exhibits no post-release transient behavior, power level drops below -13 dBm. .

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Test Outcome: Transient Frequency within limits → Pass.



Test Condition: 174 MHz, 125 mW. Frequency Up to 100 mS

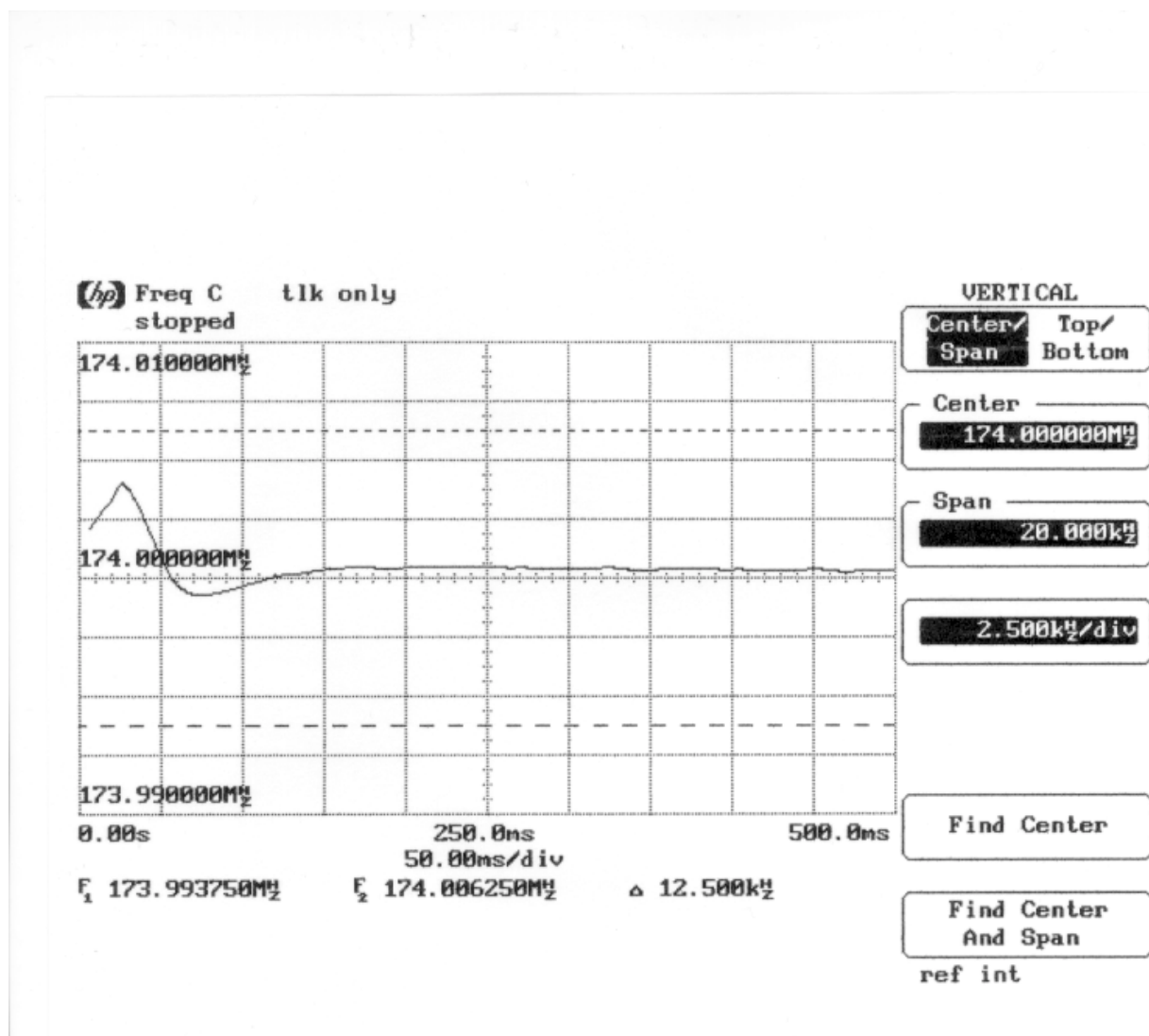
Test Limit: ± 12.5 kHz within 5 mS, ± 6.25 kHz within 25 mS

Test Indication: Transient Frequency $< \pm 6.25$ kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits → Pass.

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Test Condition: 174 MHz, 125 mW. Frequency Up to 500 mS

Test Limit: ±12.5 kHz within 5 mS, ±6.25 kHz within 25 mS

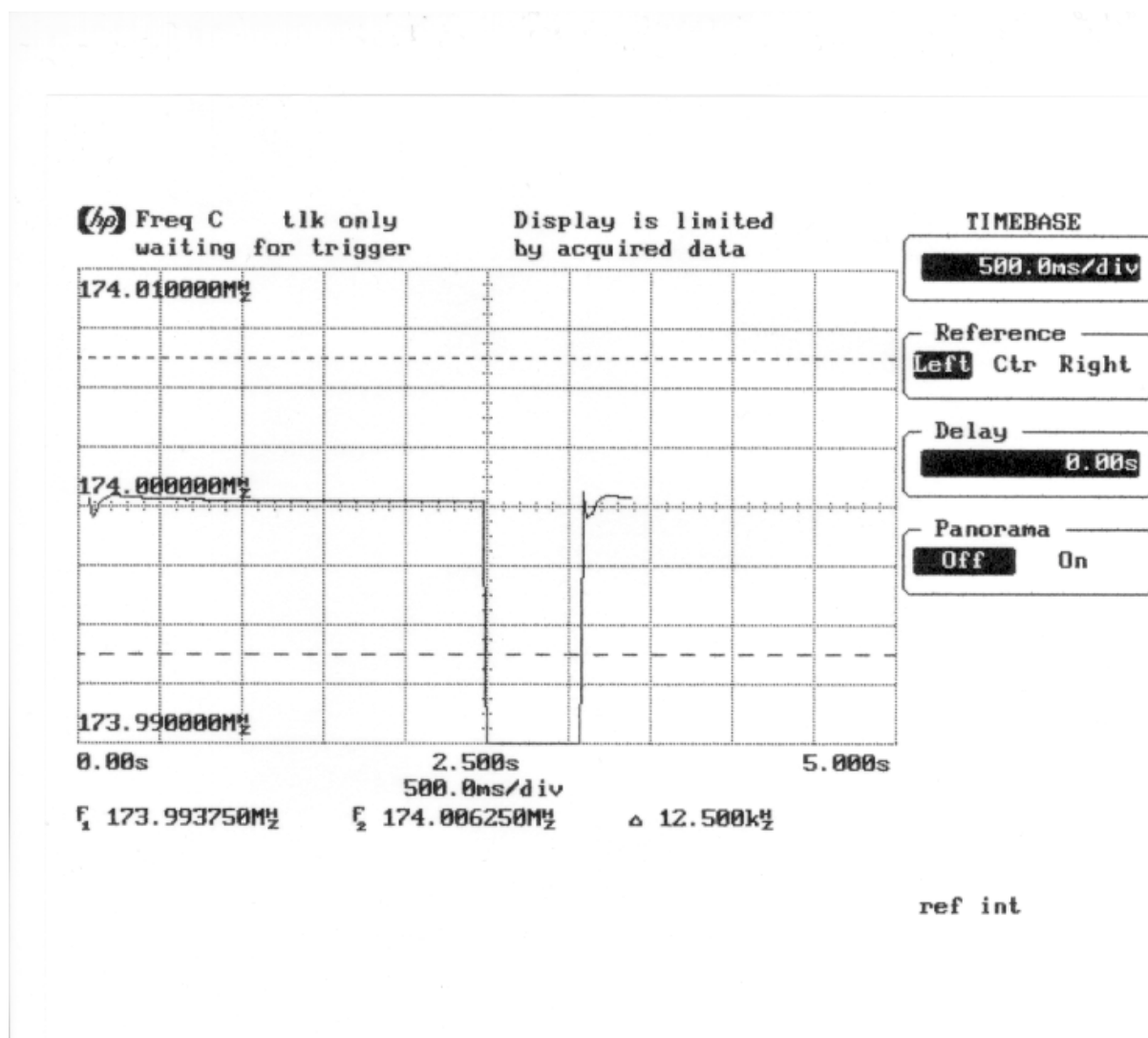
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Test Indication: Transient Frequency < ± 6.25 kHz for all times beyond t_{on} .

Test Outcome: Transient Frequency within limits $\rightarrow$ Pass.



Test Condition: 174 MHz, 125 mW. Transmitter Release Transient Frequency.

Test Limit: ± 12.5 kHz within 5 mS of t_{off}

Test Indication: Transmitter exhibits no post-release transient behavior, power level drops below -13 dBm. .



Test Outcome: Transient Frequency within limits → Pass.

6. 2.987 (a), (b) Modulation Characteristics

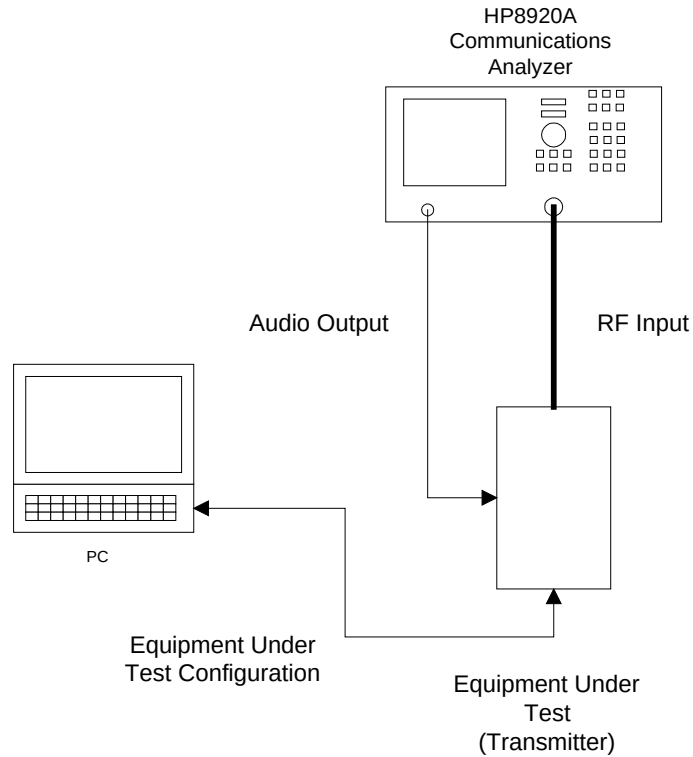
a) Test Requirement

(a) For voice modulated transmitter a frequency response curve of the audio processor between the microphone and modulator must be submitted.

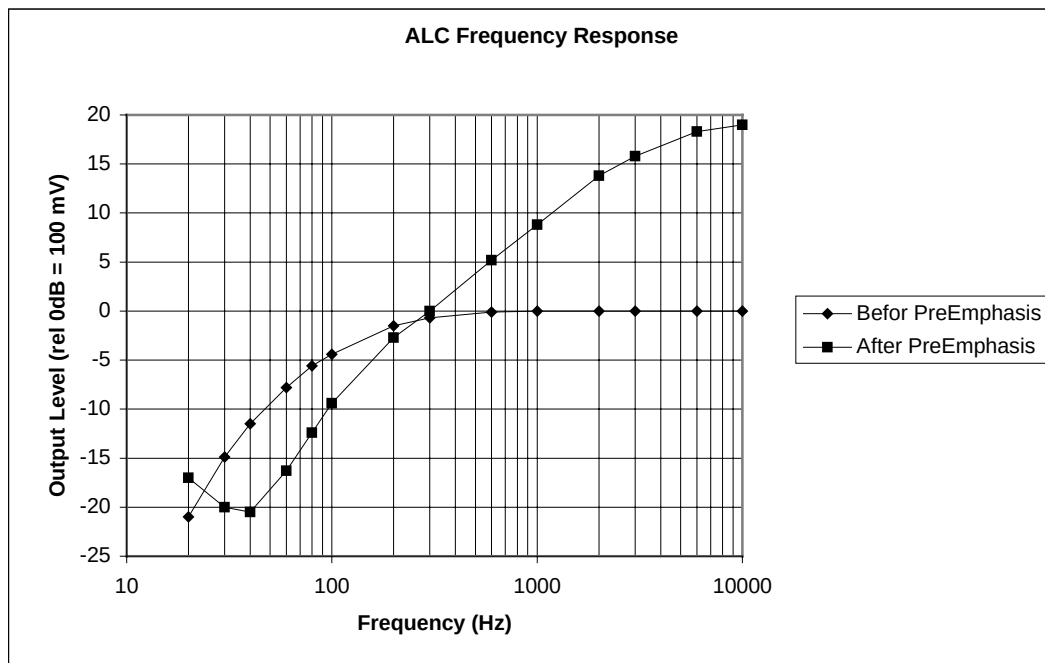
(b) A curve of frequency deviation versus level must be made across the range of input audio frequencies.

The test is configured such that the audio generator presents a source impedance of 4.3 k-Ohms to the audio circuitry, simulating the presence of the microphone.

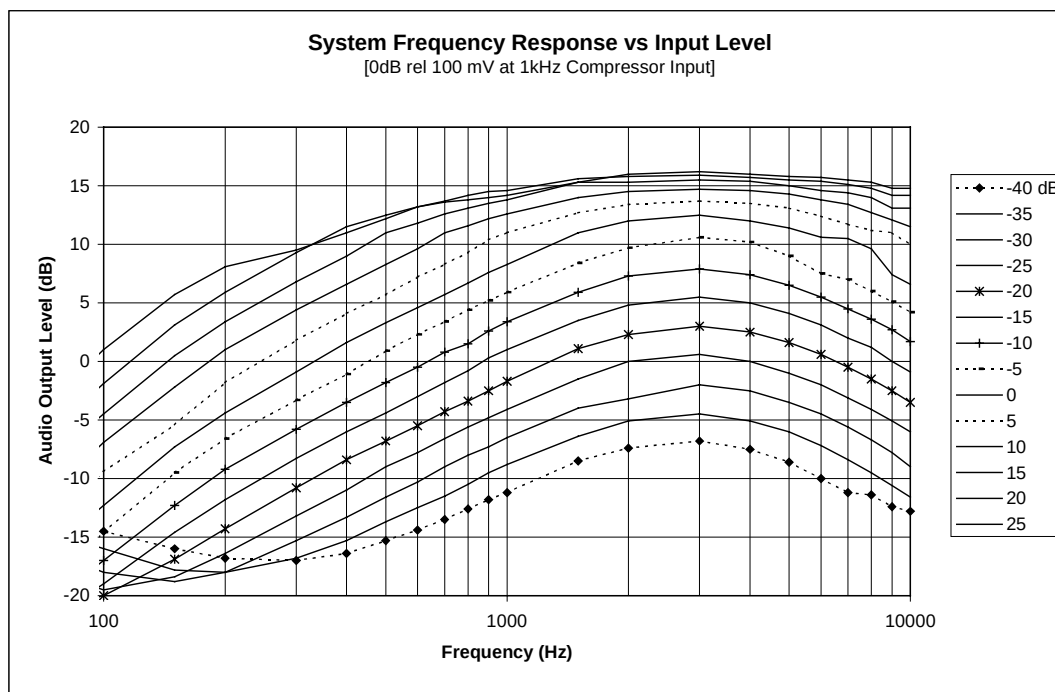
b) Test Configuration (Deviation versus Level)



c) Test Conditions and Indications: Audio Responses



ALC Mode Frequency Response



2:1 Dynamic Range Compressor Frequency Response

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d) Test Conditions and Indications: Peak Frequency Deviation versus Audio Level

Test Conditions: 162 MHz, 125 mW.

ALC: Automatic Leveling Control.

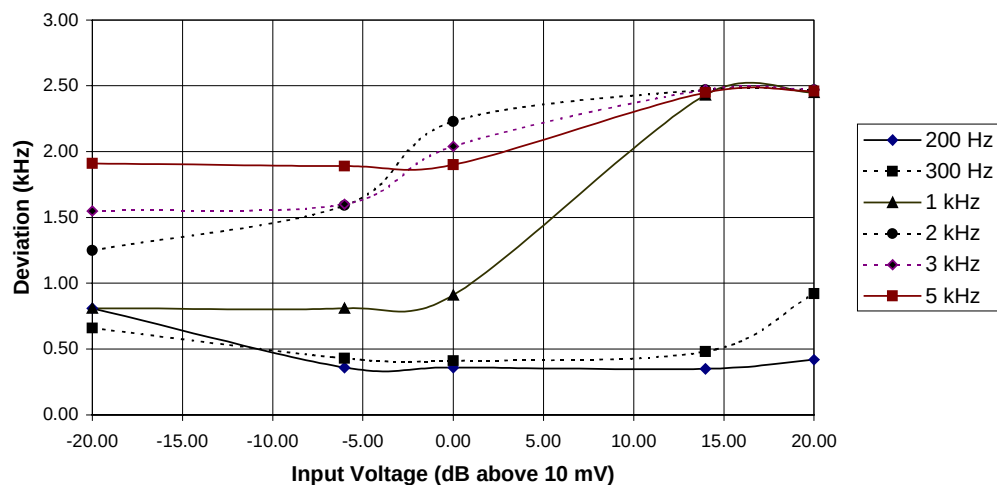
Comp. : 2:1 Dynamic Range Compressor

Peak Frequency Deviation (kHz):

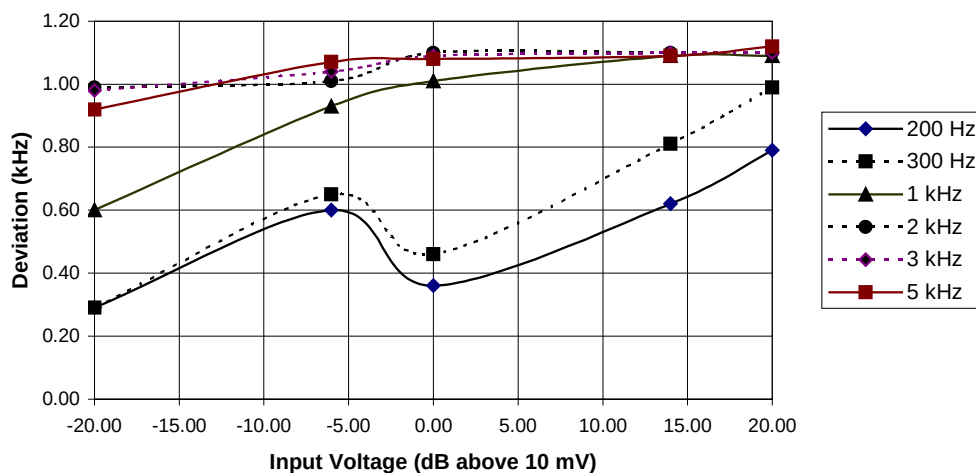
Vin (mV) =		1	5	10	50	100
Vin (dB 10mV) =		-20.00	-6.02	0.00	13.98	20.00
Mode	fm (Hz)	Vin=1mV	Vin=5mV	Vin=10mV	Vin=50mV	Vin=100mV
ALC	200	0.81	0.36	0.36	0.35	0.42
	300	0.66	0.43	0.41	0.48	0.92
	1k	0.81	0.81	0.91	2.43	2.45
	2k	1.25	1.59	2.23	2.47	2.47
	3k	1.55	1.60	2.04	2.47	2.47
	5k	1.91	1.89	1.90	2.45	2.46
Comp.	200	0.29	0.60	0.36	0.62	0.79
	300	0.29	0.65	0.46	0.81	0.99
	1k	0.60	0.93	1.01	1.09	1.09
	2k	0.99	1.01	1.10	1.10	1.10
	3k	0.98	1.04	1.09	1.10	1.10
	5k	0.92	1.07	1.08	1.09	1.12



ALC Mode Modulation Characteristics



Compression Mode Modulation Characteristics



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III. Equipment List

Equipment	LSR Serial No.	Serial Number	Calibration
HP8591E Spectrum Analyzer	-	3829A07213	12/11/98
HP8920A Communication Test Set	-	3820A10282	1/5/99
HP53310 Modulation Domain Analyzer	CC000124C	On Record	12/12/95
Thermotron S-8C Temp Chamber	CC000210C	On Record	6/5/98
HP33120 Arb. Waveform Synthesizer	CC000181C	On Record	9/29/97

IV. Equipment Uncertainties

Specified Characteristic	Specified Probability Density	Specified Uncertainty
HP8591E Spectrum Analyzer		
Reference Level Accuracy	Uniform	+ / -0.3 dB +0.01 X dB from -20 dbm
Calibrator Output	Uniform	+/-0.4 dB
Absolute Amplitude Calibration Uncertainty	Uniform	+/-0.15 dB
Gigatronics 86301A Sensor Calibration Factor	Uniform	1.33%
HP53310 Modulation Domain Analyzer CHAN A ,B		
Absolute Frequency Accuracy (OPT 010)		< 5 X 10 ⁻⁹
Frequency Resolution		
Time: 2 mS/div , Tsamp=100uS, f=200 MHz	Gaussian	100 Hz rms
Time: 20 mS/div , Tsamp=1 mS, f=200 MHz	Gaussian	2 Hz rms
Time Interval Error		
Tsmp=100 uS	Gaussian	100 ps rms
Tsmp=1 mS	Gaussian	1nS rms
HP8920A Communication Test Set		
Audio Output Frequency Accuracy	Uniform	0.025%
Audio Output Level Accuracy	Uniform	+/-2% Vset +/- 50 uV
Frequency Deviation Accuracy	Uniform	+/- 4% Reading + 7 Hz rms
Thermotron S-8C Temp. Chamber		
Temperature Accuracy	Uniform	+/- 0.3 deg C

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V. Uncertainty Analysis

HP Spectrum Analyzer Total Uncertainty (-60 dBm level):

Perform Root-Sum-Square of three uncertainties to find total uncertainty for a 95% confidence level:

Uniform uncertainties specify the probability density interval $\pm a$. The variance of the uniform density is $a^2/3$.

Sum the uncorrelated variances to find the total variance:

$$\text{Total variance} = [(0.3 \text{ dB} + 0.01 \cdot 40 \text{ dB})/3 + (0.4)/3 + (0.15)/3] = 1.25/3 = 0.416$$

The uncertainty for a 95% confidence interval is 1.96 times the standard deviation:

$$\text{Total Uncertainty} = \pm 1.96 \cdot \sqrt{0.416} = 1.96 \cdot 0.644 = \pm 1.26 \text{ dB}$$